

**800V SiC N-Channel MOSFET**

**MAIN CHARACTERISTICS**

<b>I<sub>D</sub></b>	36A
<b>V<sub>DS</sub></b>	800V
<b>R<sub>DS(on)-typ</sub></b> (@V <sub>GS</sub> =18V T <sub>C</sub> =25°C)	<118mΩ(Typ:90mΩ)

**FEATURES**

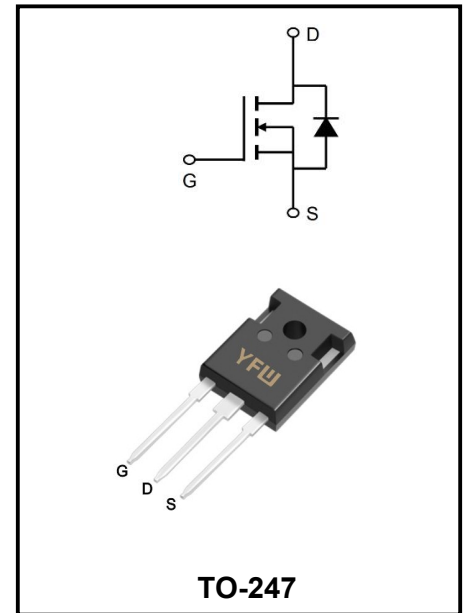
- ◆Wide Bandgap SiC MOSFET Technology
- ◆Low On-Resistance with High Blocking Voltage
- ◆Low Capacitances with High-Speed Switching
- ◆Low Reverse Recovery (Qrr)
- ◆Robust against Parasitic Turn on Even 0V Turn off Gate Voltage

**BENEFITS**

- ◆Reduced Switching Losses
- ◆Increased System Switching Frequency
- ◆Increased Power Density
- ◆Reduction of Heat Sink Requirements
- ◆Reduced EMI

**APPLICATIONS**

- ◆High Efficiency Switch
- ◆Motor driven
- ◆Ammeter
- ◆UPS power



**Maximum Ratings at T<sub>c</sub>=25°C unless otherwise specified**

Parameter	Symbol	Value	Unit
Drain-Source Voltage	<b>V<sub>DS</sub></b>	800	<b>V</b>
Gate-Source Voltage	<b>V<sub>GS</sub></b>	-10/+22	<b>V</b>
Recommended Operation Value	<b>V<sub>GSop</sub></b>	0~/+18	<b>V</b>
Continue Drain Current T <sub>c</sub> =25°C	<b>I<sub>D</sub></b>	36	<b>A</b>
Continue Drain Current T <sub>c</sub> =100°C		27	
Pulsed Drain Current	<b>I<sub>DM</sub></b>	72	<b>A</b>
Power Dissipation T <sub>c</sub> =25°C	<b>P<sub>D</sub></b>	340	<b>W</b>
Power Dissipation T <sub>c</sub> =175°C	<b>P<sub>D</sub></b>	136	<b>W</b>
Operating Temperature Range	<b>T<sub>J</sub></b>	-55 to +175	<b>°C</b>
Storage Temperature Range	<b>T<sub>STG</sub></b>	-55 to +175	<b>°C</b>
Thermal Resistance, Junction to Case	<b>R<sub>θJC</sub></b>	1.1	<b>°C/W</b>
Thermal Resistance, Junction to Ambient	<b>R<sub>θJA</sub></b>	26.8	<b>°C/W</b>

**Note1:** Pulse test: 300 μs pulse width, 2 % duty cycle

**Electrical Characteristics at Tc=25°C unless otherwise specified**

Parameter	Test Condition	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 100\mu\text{A}$	<b><math>BV_{DSS}</math></b>	800	-	-	<b>V</b>
Drain-Source Leakage Current	$V_{DS} = 800\text{ V}, V_{GS} = 0\text{ V}$	<b><math>I_{DSS}</math></b>	-	1	100	<b><math>\mu\text{A}</math></b>
Gate Leakage Current	$V_{GS} = 18\text{ V}, V_{DS} = 0\text{ V}$	<b><math>I_{GSS}</math></b>	-	-	250	<b>nA</b>
Gate-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 7.5\text{mA}$	<b><math>V_{GS(th)}</math></b>	2.7	2.8	4.5	<b>V</b>
Drain-Source On-State Resistance	$V_{GS} = 15\text{ V}, I_D = 17\text{ A}$	<b><math>R_{DS(on)}</math></b>	-	98	120	<b>m<math>\Omega</math></b>
	$V_{GS} = 15\text{ V}, I_D = 17\text{ A}, T_J = 175^\circ\text{C}$		-	77	-	
	$V_{GS} = 18\text{ V}, I_D = 17\text{ A}$		-	90	118	
	$V_{GS} = 18\text{ V}, I_D = 17\text{ A}, T_J = 175^\circ\text{C}$		-	65	-	
Internal Gate Resistance	VAC=25mV, f=100KHz f=100KHz	<b><math>R_G</math></b>	-	3	-	<b><math>\Omega</math></b>
Input Capacitance	$V_{DS}=500\text{V}$ $V_{GS}=0\text{V}$ f=100KHz	<b><math>C_{iss}</math></b>	-	1045	-	<b>pF</b>
Output Capacitance		<b><math>C_{oss}</math></b>	-	97	-	<b>pF</b>
Reverse Transfer Capacitance		<b><math>C_{rss}</math></b>	-	9	-	<b>pF</b>
Total Gate Charge(Note2)		<b><math>Q_g</math></b>	-	41	-	<b>nC</b>
Gate to Source Charge(Note2)	$I_D = 17\text{A}$ $V_{DS}=500\text{V}$ $V_{GS} = 0/15\text{V}$	<b><math>Q_{gs}</math></b>	-	10	-	<b>nC</b>
Gate to Drain Charge(Note2)		<b><math>Q_{gd}</math></b>	-	16	-	<b>nC</b>
Turn-on Delay Time	$V_{DD} = 500\text{ V}, I_D = 17\text{ A},$ $V_{GS} = 0/15\text{ V},$ $R_G = 2\ \Omega$	<b><math>t_{d(on)}</math></b>	-	19	-	<b>ns</b>
Rise Time(Note2)		<b><math>t_r</math></b>	-	115	-	<b>ns</b>
Turn-Off Delay Time(Note2)		<b><math>t_{d(OFF)}</math></b>	-	31	-	<b>ns</b>
Fall Time(Note2)		<b><math>t_f</math></b>	-	34	-	<b>ns</b>
Maximun Body-Diode Continuous Current		$V_{GS} = 0\text{ V}, T_c = 25^\circ\text{C}$	<b><math>I_S</math></b>	-	36	-
	$V_{GS} = 0\text{ V}, T_c = 100^\circ\text{C}$	-		15	-	<b>A</b>
Maximun Body-Diode Pulsed Current(Note2)		<b><math>I_{SM}</math></b>	-	72	--	<b>A</b>
Drain-Source Diode Forward Voltage	$V_{GS} = -4\text{V}, I_{SD} = 8.5\text{A}$	<b><math>V_{SD}</math></b>	-	4	-	<b>V</b>
	$V_{GS} = -4\text{V}, I_{SD} = 8.5\text{A}, T_J = 175^\circ\text{C}$		-	3.2	-	<b>V</b>
Reverse Recovery Time(Note2)	$V_{GS} = 0\text{V}, I_{SD} = 17\text{A},$ $V_R = 500\text{V}, di/dt = 550\text{A}/\mu\text{s},$ $T_j = 25^\circ\text{C}$	<b><math>t_{rr}</math></b>	-	17.8	-	<b>ns</b>
Reverse Recovery Charge(Note2)		<b><math>Q_{rr}</math></b>	-	63	-	<b>nC</b>
Peak Reverse Recovery Current		<b><math>I_{rrm}</math></b>	-	4.9	-	<b>A</b>

**Note2:Pulse test: 300 us pulse width,2 % duty cycle**

**RATINGS AND CHARACTERISTIC CURVES**

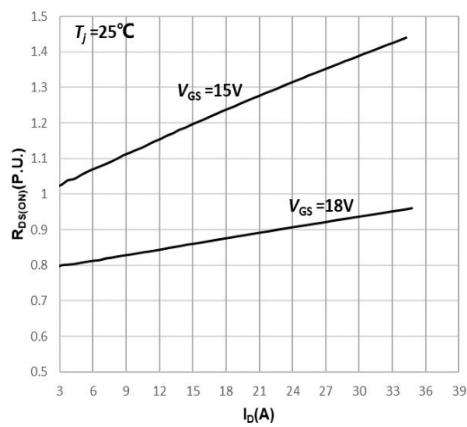
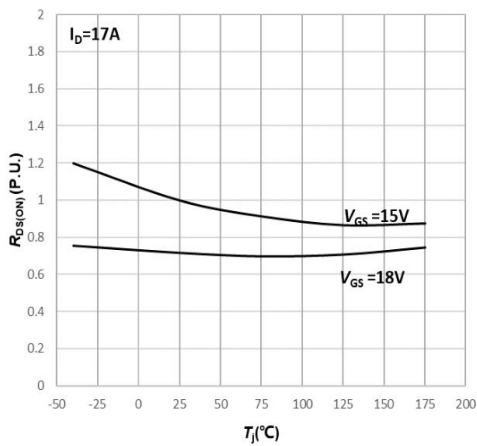
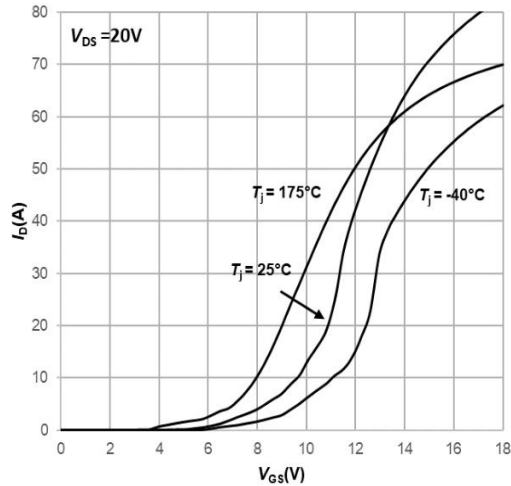
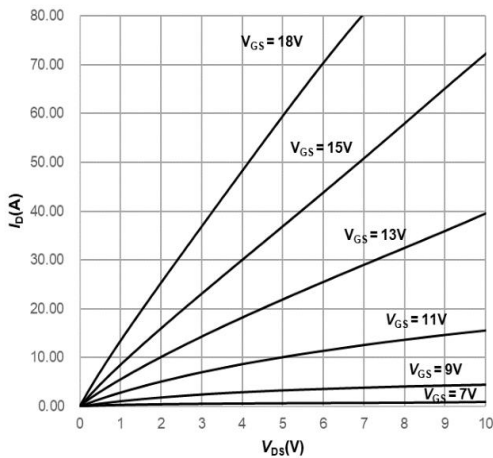
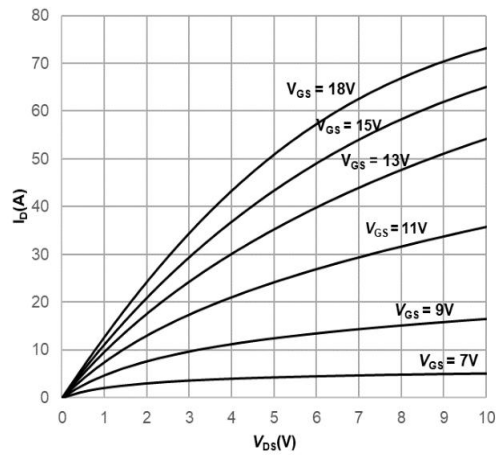
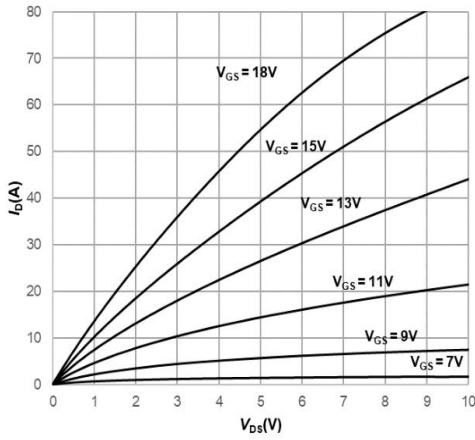


Fig5. Normalized On-Resistance vs. Temperature

Fig6. Normalized On-Resistance vs. Drain Current For Various  $V_{GS}$

**RATINGS AND CHARACTERISTIC CURVES**

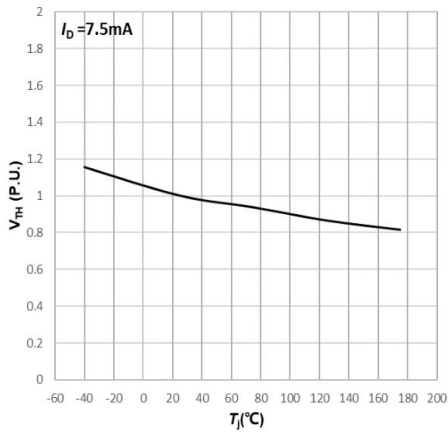


Fig7. Normalized Threshold Voltage vs. Temperature  
For  $T_j=25^{\circ}\text{C}$

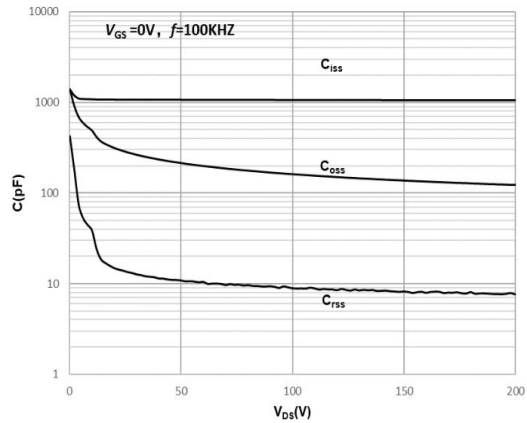


Fig8. Capacitances vs. Drain-Source Voltage (0-200V)

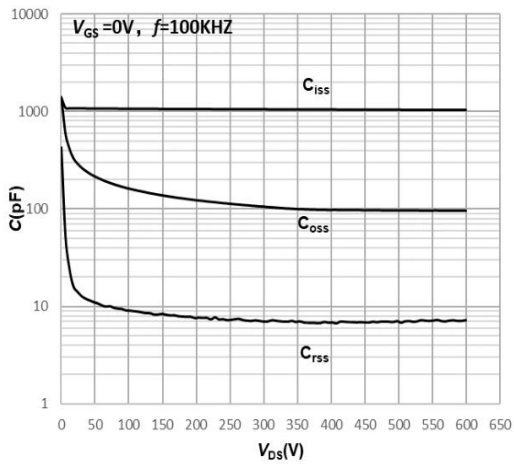


Fig9. Capacitances vs. Drain-Source Voltage (0-600V)

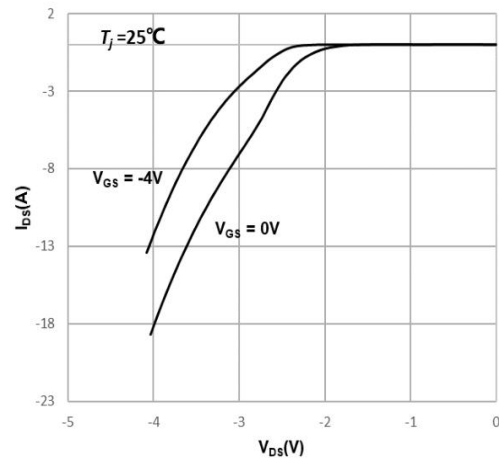


Fig10. Body Diode Characteristics

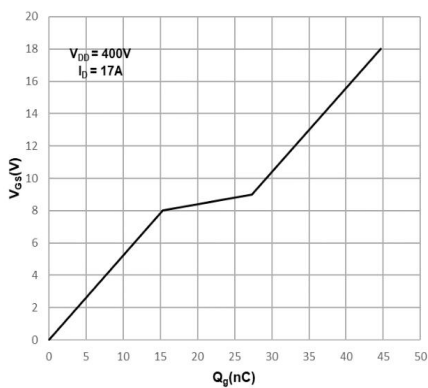


Fig11. Typical Gate Charge

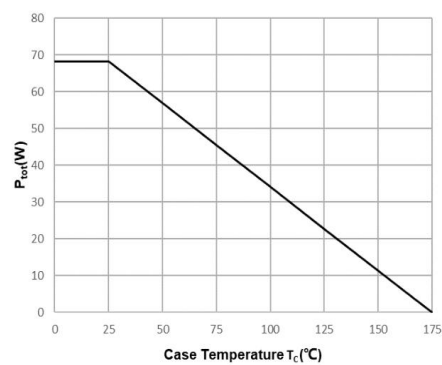
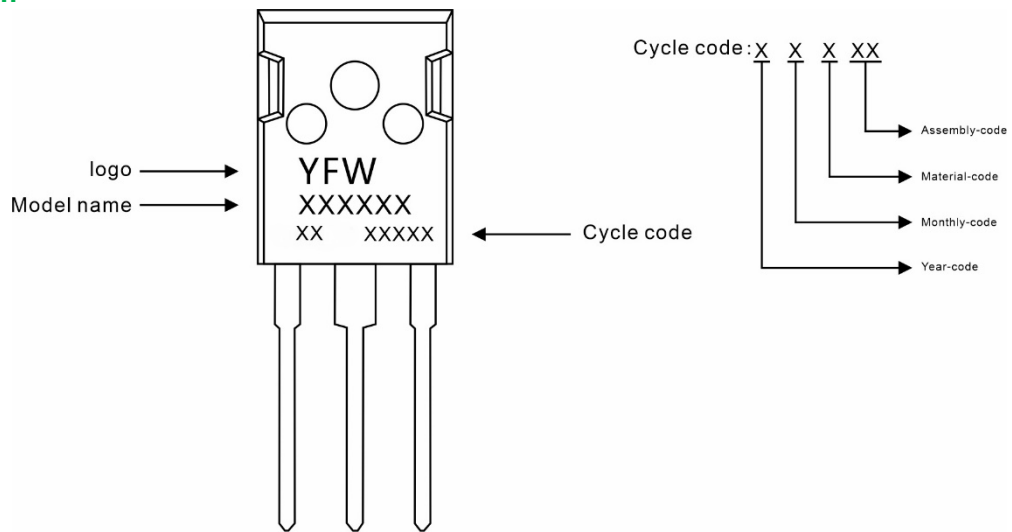


Fig12. Power Dissipation vs. Case Temperature

**Marking Diagram**



**Ordering information**

Model name	Package	Unit Weight	Base Quantity	Packing Quantity
YFWM309065APG3	TO-247	0.209oz(5.93g)	30pcs/tube	600PCS/Box 2400PCS/Carton

**Package Dimensions**

**TO-247**

Symbol	Dimensions in mm		Dimensions in Inch	
	Min.	Max.	Min.	Max.
A	4.90	5.10	0.193	0.201
A1	1.90	2.10	0.075	0.083
A2	2.29	2.54	0.090	0.100
b	1.00	1.40	0.039	0.055
b1	2.00	2.20	0.079	0.087
b2	3.00	3.20	0.118	0.126
c	0.50	0.70	0.020	0.028
D	15.75	16.05	0.620	0.632
E	20.20	20.80	0.795	0.819
e	5.45 (BSC)		0.215 (BSC)	
e1	10.90 (BSC)		0.429 (BSC)	
F	6.05	6.25	0.238	0.246
F1	5.80	6.00	0.228	0.236
L	20.10	20.40	0.791	0.803
L1	4.05	4.35	0.159	0.171
Φ	3.50	3.70	0.138	0.146

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